## Search Notes



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Applicant(s)/Patent Under Reexamination

TANAKA ET AL.

Examiner

Art Unit

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SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted with Arnel Lavarias about the restriction requirement.	2/25/2008	DSC		

INTERFERENCE SEARCH				
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